

# CSD87501L 30-V Dual Common Drain N-Channel NexFET™ Power MOSFET

## 1 Features

- Low on-resistance
- Small footprint of 3.37 mm × 1.47 mm
- Ultra-low profile – 0.2-mm high
- Lead free
- RoHS compliant
- Halogen free
- Gate ESD protection

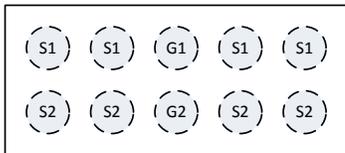
## 2 Applications

- Battery management
- Battery protection
- USB Type-C / PD

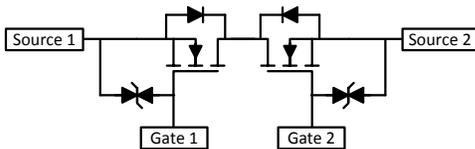
## 3 Description

This 30-V, 6.6-mΩ, 3.37-mm × 1.47-mm LGA Dual NexFET™ power MOSFET is designed to minimize resistance and gate charge in a small footprint. Its small size and common drain configuration make the device ideal for multi-cell battery pack applications and small handheld devices.

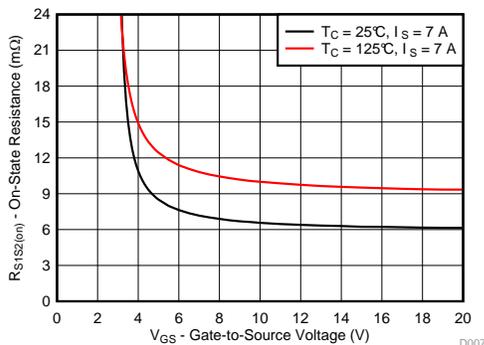
Top View



Configuration



$R_{S1S2(on)}$  vs  $V_{GS}$



## Product Summary

$T_A = 25^\circ\text{C}$		TYPICAL VALUE		UNIT
$V_{S1S2}$	Source-to-Source Voltage	30		V
$Q_g$	Gate Charge Total (4.5 V)	15		nC
$Q_{gd}$	Gate Charge Gate-to-Drain	6.0		nC
$R_{S1S2(on)}$	Source-to-Source On-Resistance	$V_{GS} = 4.5\text{ V}$	9.3	mΩ
		$V_{GS} = 10\text{ V}$	6.6	
$V_{GS(th)}$	Threshold Voltage	1.8		V

## Device Information<sup>(1)</sup>

DEVICE	MEDIA	QTY	PACKAGE	SHIP
CSD87501L	7-Inch Reel	3000	3.37 mm × 1.47 mm Land Grid Array Package	Tape and Reel
CSD87501LT	7-Inch Reel	250		

(1) For all available packages, see the orderable addendum at the end of the data sheet.

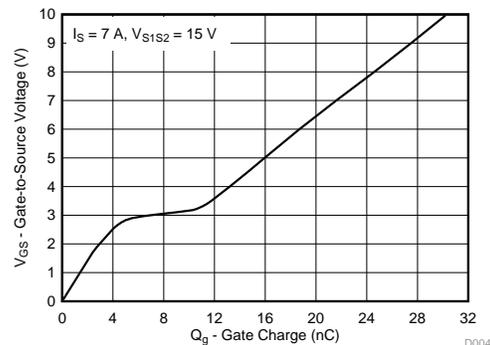
## Absolute Maximum Ratings

$T_A = 25^\circ\text{C}$		VALUE	UNIT
$V_{S1S2}$	Source-to-Source Voltage	30	V
$V_{GS}$	Gate-to-Source Voltage	±20	V
$I_S$	Continuous Source Current <sup>(1)</sup>	14	A
$I_{SM}$	Pulsed Source Current <sup>(2)</sup>	72	A
$P_D$	Power Dissipation	2.5	W
$V_{(ESD)}$	Human-Body Model (HBM)	2	kV
$T_J, T_{stg}$	Operating Junction, Storage Temperature	-55 to 150	°C

(1) Typical  $R_{\theta JA} = 50^\circ\text{C/W}$  on a 1-in<sup>2</sup>, 2-oz Cu pad on a 0.06-in thick FR4 PCB.

(2) Typical min Cu  $R_{\theta JA} = 135^\circ\text{C/W}$ , pulse duration ≤ 100 μs, duty cycle ≤ 1%.

Gate Charge



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## 4 Revision History

<b>Changes from Revision A (April 2015) to Revision B</b>	<b>Page</b>
• Added <i>Receiving Notification of Documentation Updates</i> section and <i>Community Resources</i> section .....	<b>7</b>
• Added Pin Configuration table in the <i>Mechanical, Packaging, and Orderable Information</i> section .....	<b>8</b>

<b>Changes from Original (February 2015) to Revision A</b>	<b>Page</b>
• Extended Y axis in <a href="#">Figure 9</a> down to 0.01 A .....	<b>4</b>

## 5 Specifications

### 5.1 Electrical Characteristics

 $T_A = 25^\circ\text{C}$  unless otherwise stated

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
<b>STATIC CHARACTERISTICS</b>						
$BV_{S1S2}$	Source-to-source voltage	$V_{GS} = 0\text{ V}, I_S = 250\ \mu\text{A}$	30			V
$I_{S1S2}$	Source-to-source leakage current	$V_{GS} = 0\text{ V}, V_{S1S2} = 24\text{ V}$			1	$\mu\text{A}$
$I_{GSS}$	Gate-to-source leakage current	$V_{S1S2} = 0\text{ V}, V_{GS} = 20\text{ V}$			10	$\mu\text{A}$
$V_{GS(th)}$	Gate-to-source threshold voltage	$V_{S1S2} = V_{GS}, I_S = 250\ \mu\text{A}$	1.3	1.8	2.3	V
$R_{S1S2(on)}$	Source-to-source on-resistance	$V_{GS} = 4.5\text{ V}, I_S = 7\text{ A}$		9.3	11.0	m $\Omega$
		$V_{GS} = 10\text{ V}, I_S = 7\text{ A}$		6.6	7.8	
$g_{fs}$	Transconductance	$V_{S1S2} = 3\text{ V}, I_S = 7\text{ A}$		48		S
<b>DYNAMIC CHARACTERISTICS<sup>(1)</sup></b>						
$C_{iss}$	Input capacitance	$V_{GS} = 0\text{ V}, V_{S1S2} = 15\text{ V}, f = 1\text{ MHz}$		1620	2110	pF
$C_{oss}$	Output capacitance			189	246	pF
$C_{rss}$	Reverse transfer capacitance			152	198	pF
$R_G$	Series gate resistance			300	450	$\Omega$
$Q_g$	Gate charge total (4.5 V)	$V_{S1S2} = 15\text{ V}, I_S = 7\text{ A}$		15	20	nC
$Q_g$	Gate charge total (10 V)			31	40	nC
$Q_{gd}$	Gate charge gate-to-drain			6.0		nC
$Q_{gs}$	Gate charge gate-to-source			5.0		nC
$Q_{g(th)}$	Gate charge at $V_{th}$			2.5		nC
$Q_{oss}$	Output charge		$V_{S1S2} = 15\text{ V}, V_{GS} = 0\text{ V}$		7.6	
$t_{d(on)}$	Turn on delay time	$V_{S1S2} = 15\text{ V}, V_{GS} = 10\text{ V}, I_{S1S2} = 7\text{ A}, R_G = 0\ \Omega$		164		ns
$t_r$	Rise time			260		ns
$t_{d(off)}$	Turn off delay time			709		ns
$t_f$	Fall time			712		ns

(1) Dynamic characteristics values specified are per single FET.

### 5.2 Thermal Information

 $T_A = 25^\circ\text{C}$  unless otherwise stated

THERMAL METRIC		MIN	TYP	MAX	UNIT
$R_{\theta JA}$	Junction-to-ambient thermal resistance <sup>(1)</sup>		135		$^\circ\text{C/W}$
	Junction-to-ambient thermal resistance <sup>(2)</sup>		50		

(1) Device mounted on FR4 material with minimum Cu mounting area.

(2) Device mounted on FR4 material with 1-in<sup>2</sup> (6.45-cm<sup>2</sup>), 2-oz (0.071-mm thick) Cu.

### 5.3 Typical MOSFET Characteristics

$T_A = 25^\circ\text{C}$  unless otherwise stated

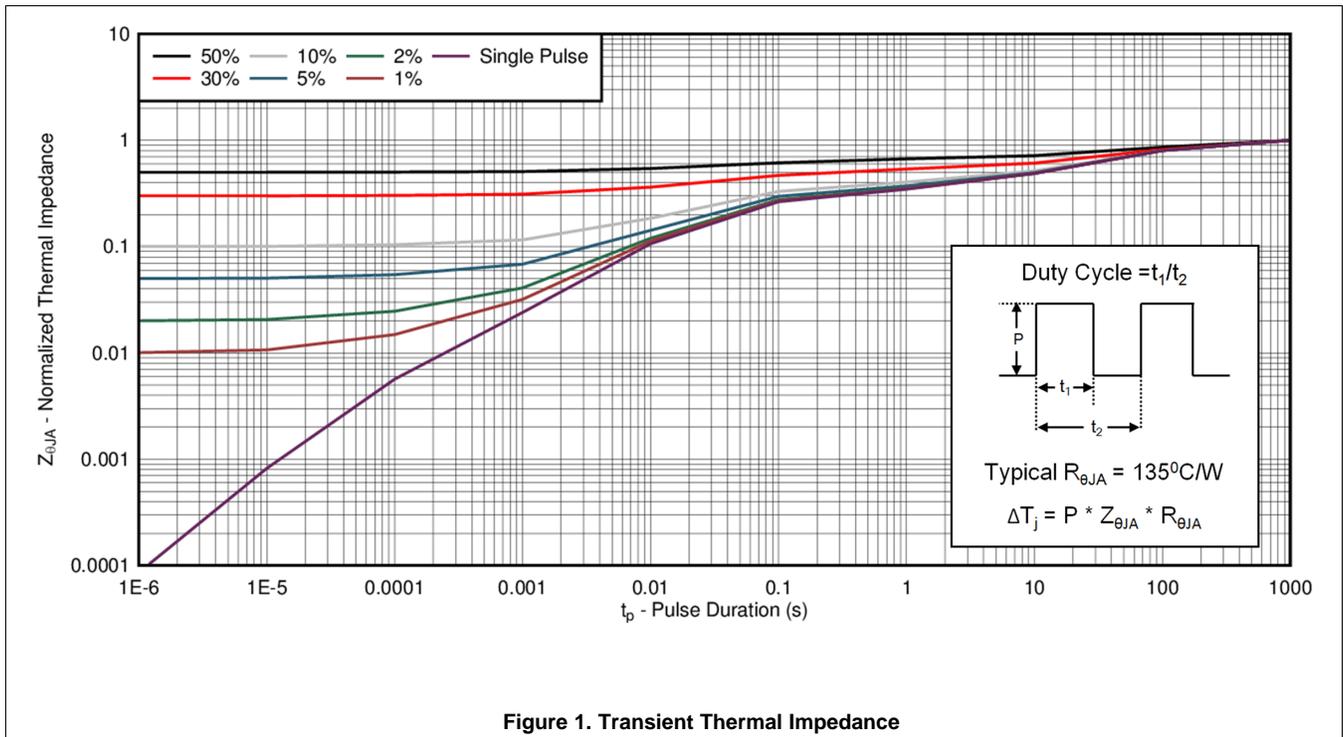


Figure 1. Transient Thermal Impedance

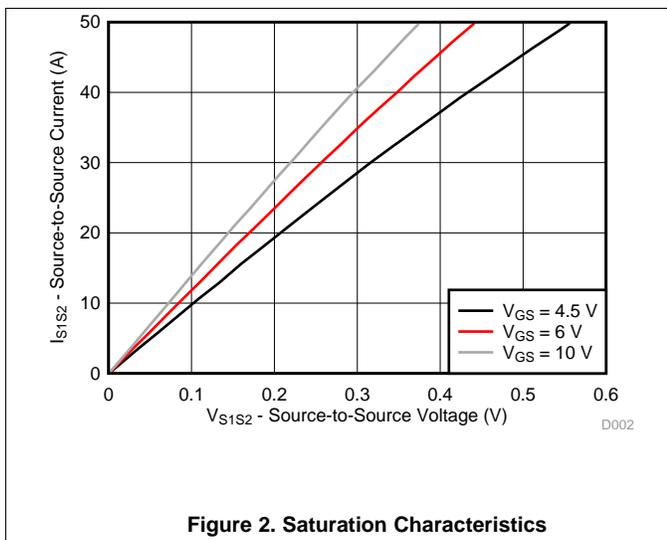


Figure 2. Saturation Characteristics

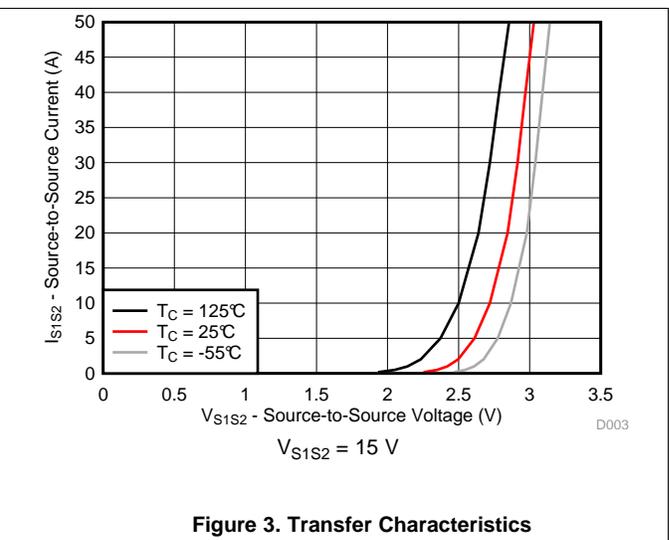
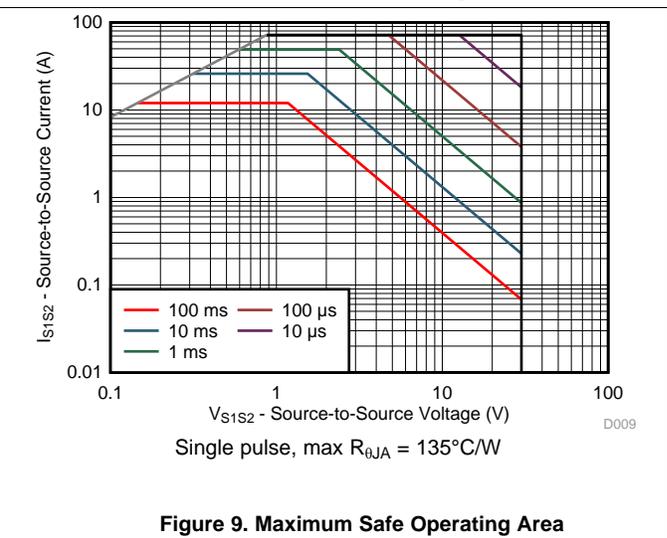
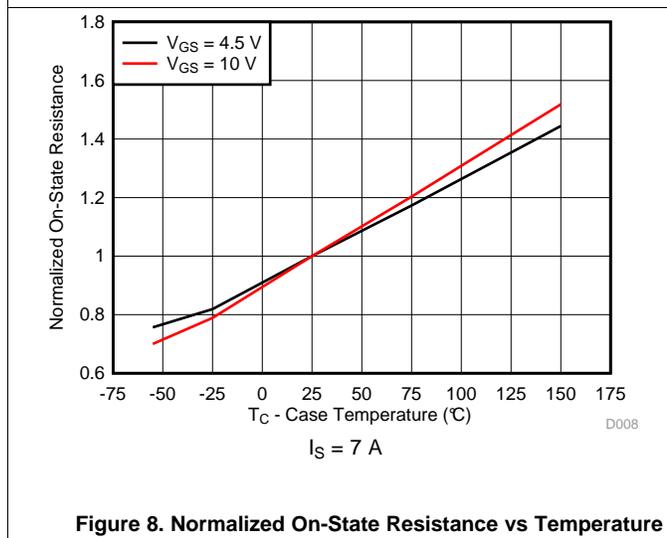
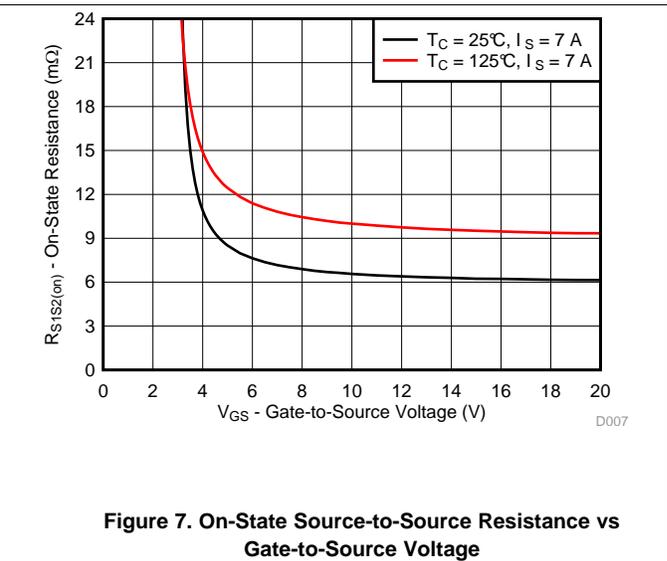
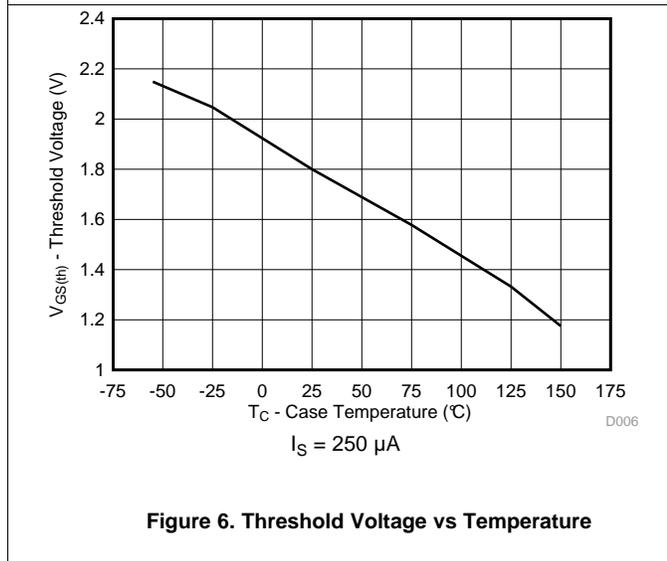
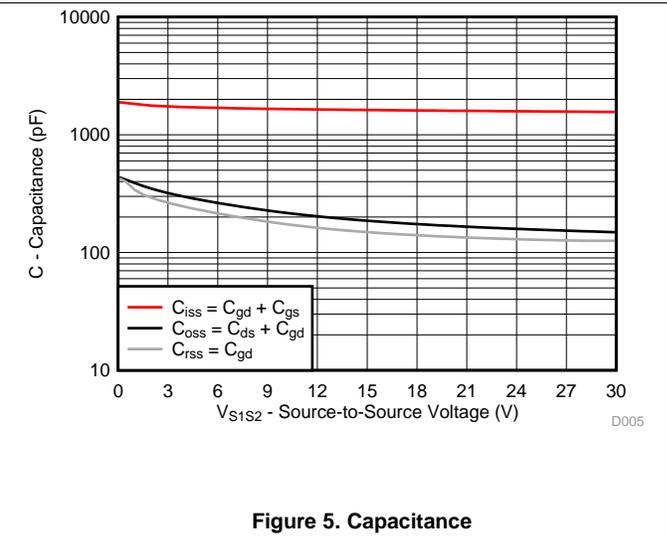
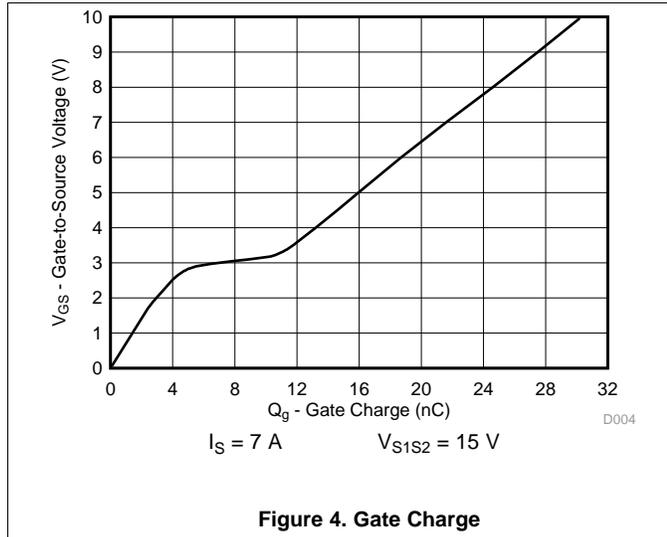


Figure 3. Transfer Characteristics

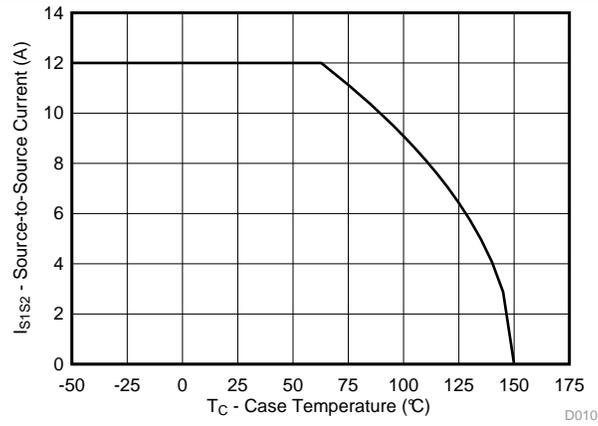
Typical MOSFET Characteristics (continued)

T<sub>A</sub> = 25°C unless otherwise stated



**Typical MOSFET Characteristics (continued)**

$T_A = 25^\circ\text{C}$  unless otherwise stated



**Figure 10. Maximum Source Current vs Temperature**

## 6 Device and Documentation Support

### 6.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

### 6.2 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

**TI E2E™ Online Community** *TI's Engineer-to-Engineer (E2E) Community*. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

**Design Support** *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

### 6.3 Trademarks

NexFET, E2E are trademarks of Texas Instruments.  
All other trademarks are the property of their respective owners.

### 6.4 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

### 6.5 Glossary

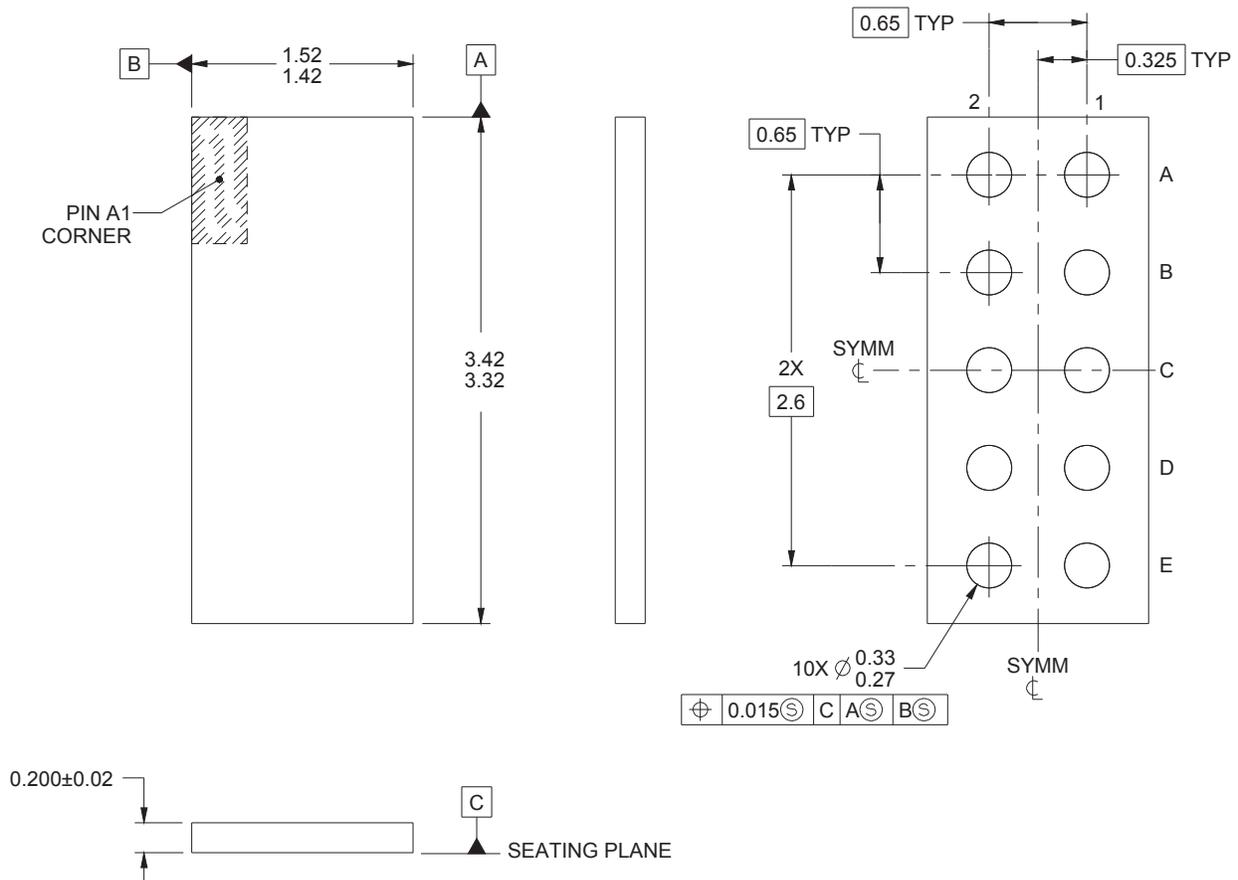
[SLYZ022](#) — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

## 7 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

### 7.1 Package Dimensions

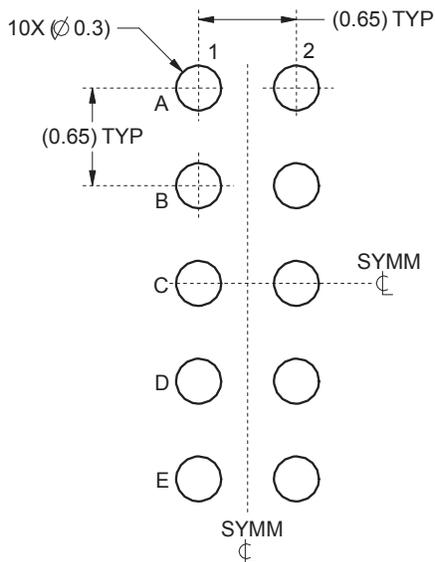


All dimensions in millimeters.

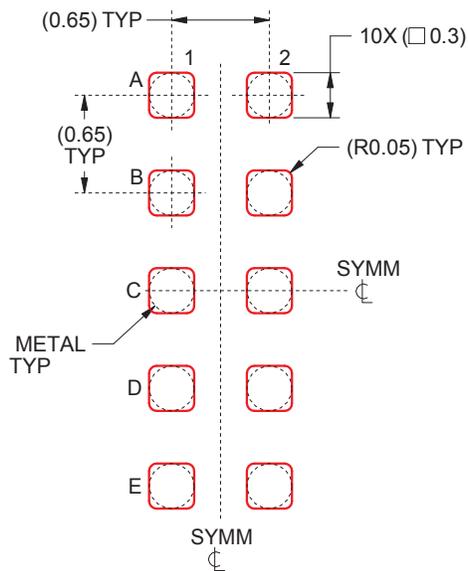
**Table 1. Pin Configuration**

Position	Designation
A1, B1, D1, E1	Source 1
C1	Gate 1
A2, B2, D2, E2	Source 2
C2	Gate 2

### 7.2 Recommended PCB Pattern



### 7.3 Recommended Stencil Pattern



All dimensions are in millimeters unless otherwise noted.

**PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
CSD87501L	ACTIVE	PICOSTAR	YJG	10	3000	RoHS & Green	NIAU	Level-1-260C-UNLIM		CSD87501	<a href="#">Samples</a>
CSD87501LT	ACTIVE	PICOSTAR	YJG	10	250	RoHS & Green	NIAU	Level-1-260C-UNLIM	-55 to 150	CSD87501	<a href="#">Samples</a>

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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